

Search Notes

Application/Control No.

10/701,156

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

IWATA, YUJI

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	updated	8/30/2006	SWH
392	updated	8/30/2006	SWH
34	updated	8/30/2006	SWH
219	updated	8/30/2006	SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPGPUB text search (see attached)	6/30/2006	SWH